NANO 703/703L – Fall 2018 Instrumentation for Characterization of Nanomaterials Course Schedule

WEEK	DATE	TEXT	LECTURE
1	M-8/20	TEM: PART 1-BASICS	Notes: Transmission Electron Microscopy
	W-8/22	(Ch. 1-6,8,9)	Notes: Scattering & Diffraction
	F-8/24		
2	M-8/27		Notes: Elastic Scattering
	W-8/29		Notes: Inelastic Scattering
	F-8/31		Notes: Electron Sources
3	W-9/5		Notes: Lenses, Apertures, & Resolution
	F-9/7		Notes: Pumps & Holders
4	M-9/10		Notes: The Instrument
	W-9/12	TEM: PART 2-DIFFRACTION	Notes: Electron Diffraction
	F-9/14	(Ch. 11-14,16-21)	Notes: Reciprocal Space
5	M-9/17		Notes: Diffracted Beams
	W-9/19		Notes: Dynamical Diffraction
	F-9/21		
6	M-9/24		Notes: Diffraction from Crystals
	W-9/26		Notes: Diffraction from Small Volumes
	F-9/28		
7	M-10/1		Notes: Indexing Diffraction Patterns
	W-10/3		Notes: Kikuchi Diffraction
	F-10/5		Notes: Convergent Beam Diffraction
8	W-10/10		Review: Exam I
	F-10/12		Notes: Uses of CBED
9	M-10/15	TEM: PART 3-IMAGING	Notes: Amplitude Contrast
	W-10/17	(Ch. 22-26,38,30,31)	Notes: Phase Contrast
	F-10/19		Notes: Column Approximation
10	M-10/22		Notes: Planar Defects
	W-10/24		Notes: Strain Fields
	F-10/26		
11	M-10/29		Notes: High-Resolution Imaging
	W-10/31		Notes: Image Simulation
	F-11/2		Notes: Electron Tomography
13	M-11/5	TEM: PART 4-SPECTROMETRY	Notes: Energy-Dispersive X-Ray Spectrometry
	W-11/7	(Ch. 32-34)	Notes: Quantitative EDX
	F-11/9		
14	W-11/14		Review: Exam II
	F-11/16	XRD: Properties of X-Rays	Notes: X-Ray Diffraction
15	M-11/19		Notes: Intensity Factors
16	M-11/26		Notes: Powder XRD
	W-11/28		Notes: XRD of Epitaxial Films
	F-11/30		•
17	M-12/3	Conclusion	Review-Final

Exam I: W-10/10, 7:00-8:50 PM, EP 251A Exam II: W-11/14, 7:00-8:50 PM, EP 251A

Final: TBD

EXPERIMENT	LOCATION
TEM Magnification Calibration	EP 112
TEM Diffraction Calibration	EP 112
TEM Analysis of Nanoparticles	EP 112
TEM Analysis of Carbon Nanotubes	EP 112
TEM Sample Prep I-Ultramicrotomy	EP 211
TEM Sample Prep II-Polishing, Dimpling, Ion Milling	EP 240
Atomic Force Microscopy	MI 127
Raman Spectroscopy	MI 234
Optical Spectroscopy-Absorbance and Photoluminesence	EP 211
Double-Crystal X-Ray Diffraction	EP 109
Scanning Electron Microscopy	MI 234
Ellipsometry	EP 211
Convergent Beam Electron Diffraction	EP 112
TEM Dark-Field Imaging	EP 112
Scanning TEM/Energy Dispersive X-ray Spectrometry	EP 112
Transmission Electron Tomography	EP 112
other	To Be Announced

Note: Experiment list is subject to change.